

User Guide for ATMEL Serial Firmware DataFlash® Verilog model

1. Introduction:

This documentation describes the verification environment and the features that offer to a test engineer.

2. Verilog Model for DataFlash:

AT26DFxxx.v module supports four ATMEL DataFlash models namely AT25DF041A, AT26DF081A, AT26DF161A, AT26DF321. It has a testbench **testbench_AT26DFx.v**. Top file where model and testbench getting instantiated is **topx_testbench.v** file.

3. Introduction of modules:

Device model:

AT26DFxxx model will receive opcode, data from the SI line. Some of the tasks in this model are created for performing internal operations like programming the memory, erasing the memory, checking protection status of particular sector of memory, Protection and Unprotection of sectors. Few tasks are created to retrieve 8-bit data from memory and to send it through SO, sending protection status of sectors in the SO line.

Testbench:

This module is responsible for sending opcode, address and data. Based on which particular trigger input asserted, corresponding opcode, address and data transfer will start. For example, if **tr_byt_prog** is asserted, then the byte programming opcode will be transferred in **serial_in** line in serial manner. Then the address obtained through **m_address** is transmitted serially. **data_num** will intimate the number of data to be written into the memory. Based on the **data_num** value, data in **w_data** will be transmitted serially through **serial_in**. The **testbench_AT26DFx.v** module has **HOLDB** control. Hence this signal can be passed based on the **HOLDB** value.

Top:

topx_testbench.v module is responsible for selecting the device for which the model has to work, sending opcode, address and data in SI line and obtaining the read array data from SO line. It also passes all the parameter needed for the device model (**AT26DFxxx.v**) internally. It contains all the test cases to test the model for each device model (AT25DF041A, AT26DF081A, AT26DF161A, and AT26DF321) and also for all the possibilities of error conditions.

4. Signals and Events of AT26DFxxx.v module:

AT26DFxxx model will receive opcode, data from the SI line. Some of the tasks in this model are created for performing internal operations like programming the memory, erasing the memory, checking protection status of particular sector of memory, Protection and Unprotection of sectors. Few tasks are created to retrieve 8-bit data from memory and to send it through SO, sending protection status of sectors in the SO line.

4.1 Port Signals:

Input ports for this model are: CSB, SCK, SI, WPB, and HOLDB. **Output port** for this model is SO.

CSB is Chip Select Signal. Generated from testbench and is a active low signal.

SCK is Serial Clock Signal. Generated from testbench.

SI is Serial Input. Generated from testbench and provides model with either opcode, address or data.

WPB is Write Protect signal. Generated from testbench and is a active low signal.

HOLDB is a Hold signal. Generated from testbench and is a active low signal. (This port will not be available for AT26DF321 model since this model doesn't support hold feature)

SO is a output port for the model. It can provide data, status register content, Manufacture ID and protection status of memory.

4.2 Top level signals:

memory is an array of 8 bit memory of selected device.

MEMSIZE specifies the maximum memory size for each device.

status_reg signal contains value of the 8-bit Status register register.

sector_reg specifies the sector protection status of the sectors for selected memory model.

deep_power_down signal intimates whether the device is in Deep Power Down Mode (Login 1) or in Stand-by Mode (Logic 0).

rd_dummy is used to differentiate between Read Array low frequency (Logic 0) and high frequency (Logic 1).

seq_byte_prog signal intimates start of Sequential Byte Programming.

current_address signal stores the 24 bit address.

data_in signal stores the 8 bit data received.

read_data retrieves 8-bit data from the memory in the specified address.

SO_on enable signal for SO

SO_reg signal holds the value for SO

SPRL signal holds Sector Protection Register Locked bit status of Status register

SPM signal holds the Sequential Programming Mode status of Status register.

EPE signal holds Erase/Program Error of Status register

WPP signal Write Protect Pin status Status register

SWP signal holds the Software Protection Status of Status register

WEL signal holds the Write Enable Latch of Status register
RDYnBSY signal holds the Ready/Busy status of Status register

4.3 List of events:

EDPD : Enter into Deep Power Down
RDPD : Resume from Deep Power Down
RA : Read Array (both low frequency and high frequency)
BE4 : Block Erase of 4KB block
BE32 : Block Erase of 32KB block
BE64 : Block Erase of 64KB block
CE : Chip erase
BP : Byte Programming
SBP : Sequential Byte programming (This event will not be asserted for AT26DF321 model since this model doesn't support Sequential Byte programming feature)
WE : Write Enable
WD : Write Disable
PS : Protect Sector
UPS : Unprotect Sector
RSPR : Read Sector Protection Register
RSR : Read Status Register
WSR : Write Status Register
MIR : Manufacture Id Read

4.4 List of parameters:

fRDLF : SCK Frequency for read Array Low frequency in MHz
fSCK : Serial clock (SCK) Frequency in MHz
tDIS : Output Disable time in ns
tV : Output Valid time in ns
tOH : Output Hold time in ns
tSCKH : SCK High time in ns
tSCKL : SCK Low time in ns
tHLQZ : HOLD! Low to Output High-z time in ns
tHHQX : HOLD! High to Output Low-z time in ns
tEDPD : Chip Select high to Deep Power-down time in ns
tRDPD : Chip Select high to Stand-by Mode time in ns
tWRSR : Write Status Register Time in ns
tSECP : Sector Protect Time in ns
tSECUP : Sector Unprotect Time in ns
tBP : Byte Program Time in ns
tPP : Page Program Time in ns
tBLKE4 : Block Erase Time 4-kB time in ns
tBLKE32: Block Erase Time 32-kB time in ns

tBLKE64: Block Erase Time 64-kB time in ns
tCHPE : Chip erase time in ns
DEVICE : Specifies the selected card model
PRELOAD: memory preloading condition
MEMORY_FILE: memory preload file

5 Tasks used in AT26DFxxx.v module:

Some of the tasks in AT26DFxxx model are created to receive opcode, data from the SI line. Some of the tasks are created for performing internal operations like programming the memory, erasing the memory, checking protection status of particular sector of memory, Protection and Unprotection of sectors. Few tasks are created to retrieve 8-bit data from memory and to send it through SO, sending protection status of sectors in the SO line.

get_opcode: This task receives 8 bits of opcode.
get_data: This task receives 8 bits of data.
read_out_array: This task is to read 8-bit data from main Memory
protect_sector: This task is used for Sector protection
unprotect_sector: This task is used for Sector Unprotection
check_protection: This task is used to Check Sector Protection
send_protection_status: This task is used for Sending Sector Protection status
page_program: This task is used to receive data for byte / page programming
byte_program: This task is used for Byte program / Page Program / Sequential Byte programming for devices
erase_4kb: This task is used to Erase a 4kB block
erase_32kb: This task is used to Erase a 32kB block
erase_64kb: This task is used to Erase a 64kB block
erase_chip: This task is used for Chip Erase.

6. Status and Error printing of AT26DFxxx.v module:

Based on the opcode received, any of the following will appear on the screen as the model is being compiled:

Opcode(ab) for Resume from Deep Power-down received
if the device is in Deep Power-down, and if any other opcode except “ab” appears, then the following print will appear:
Opcode XX is not allowed: device in Deep Power-down
Opcode(0b) for Read Array received
Opcode(03) for Read Array (Low Freq) received
Opcode(20) for 4 KB Block erase received
Opcode(52) for 32 KB Block erase received
Opcode(d8) for 64 KB Block erase received
Opcode(c7) for Chip erase received
Opcode(02) Byte Program received

Opcode(af) Sequential Byte Program received
if device selected is AT26DF321, then this printing will appear
Sequential Byte Program is not supported for device AT26DF321
Opcode(06) for Write Enable received
Opcode(04) for Write Disable received
Opcode(36) for Protect Sector received
Opcode(39) for Unprotect Sector received
Opcode(3c) for Read Sector Protection Register received
Opcode(05) for Status Register Read received
Opcode(01) for Write Status Register received
Opcode(9f) for Read Manufacturer and Device ID received
Opcode(b9) for Deep Power-down received
if none of the above opcodes received, then the following print will appear:
Unrecognized opcode XX

Inside Tasks:

In read_out_array task after receiving each byte of data in consecutive memory locations, following printing will appear:

Data: XX read from memory location XXXXXX

When calling protect_sector, following printing will appear:

Entered Protect Sector task

When entering unprotect_sector, any one of the following printing will appear:

Entered Unprotect sector for Device: AT25DF041A

Entered Unprotect sector for Device: AT26DF081A

Entered Unprotect sector for Device: AT26DF161A

Entered Unprotect sector for Device: AT26DF321

Unprotect Sector failed

if the check_protection process fails, following printing will appear:

Check Sector Protection failed

In page_program after each byte of data receiving, following printing will appear:

“One byte of data: XX received for Page Program”

In byte program after writing a byte of data in memory, following printing will appear:

“One Byte of data XX written in memory in location XXXXXX”

In erase_4kb, erase_32kb, erase_64kb and erase_chip following printing will appear respectively:

4kB Block with start address XX is going to be erased

32kB Block with start address XX is going to be erased

64kB Block with start address XX is going to be erased

Chip Erase is going to be started

Entering into Deep Power-down execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Deep Power-down command cannot be issued”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX Mhz for SPI interface. Deep Power-down is not allowed.”

At the end of operation:

“Device enters into Deep Power-down mode. Send 'Resume from Deep Power-down' to resume”

Entering into Resume from Deep Power-down execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Deep Power-down command cannot be issued”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX Mhz for SPI interface. Resume from Deep Power-down is not allowed.”

At the end of operation:

“Device Resumes from Deep Power-down mode”

Entering into Manufacturing ID Read execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Manufacturing ID Read cannot be issued”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX Mhz for SPI interface. Manufacturing ID Read is not allowed”

At the end of operation:

“Manufacture ID and Device ID of Device sent”

Entering into Status Register Read execution, following printing will appear:

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX Mhz for SPI interface. Status Register Read is not allowed.”

“Status register content of Device transmitted”

Entering into Status Register Write execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Write Status Register is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Write Status Register is not allowed.”

Any of the following print will appear based on the write status register operation.

“SPRL Software locked”

“SPRL Hardware locked. Lock cannot be done”

“SPRL Software locked. Lock cannot be done”

“SPRL Hardware locked. Unlock cannot be done”

“Sector Protection Register UnLocked”

“SPRL in unlocked state”
“SPRL locked. Global Protect/Unprotect cannot be done”
“Global Protection issued for Sector protection register”
“Global Protection issued for Sector protection register”
“Global Unprotect issued for Sector protection register”
“SPRL locked. Global Protect/Unprotect cannot be done”

if WEL bit is not set prior to write status register operation, following print will appear:

“WEL bit not set. Write Status Register is not allowed”
“Write Status Register operation completed”

Entering into Write Enable execution, following printing will appear:

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Write Enable is not allowed.”
“Write Enable Latch Set”

Entering into Write Disable execution, following printing will appear:

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Write Disable is not allowed.”
“Write Enable Latch Reset”

Entering into Read Array execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Read Array is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Read Array is not allowed”

Entering into Protect Sector execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Protect Sector is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Protect Sector is not allowed”

if WEL bit is set/SPRL is unlocked the received address is protected:

“Sector for Address XXXXXX is Protected”

If WEL bit is not set/SPRL is locked

“WEL bit not set or Sector Protection Register Locked. Protect Sector is not allowed”

Entering into Unprotect Sector execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Un-Protect Sector is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Un-Protect Sector is not allowed”

if WEL bit is set/SPRL is unlocked the received address is Unprotected:

“Sector for Address XXXXXX is UnProtected”

If WEL bit is not set/SPRL is locked”

“WEL bit not set or Sector Protection Register Locked. Un-Protect Sector is not allowed”

Entering into Read Sector Protection Register execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Read Sector Protection Register is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Read Sector Protection Register is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected”

“Sector for Address XXXXXX is Unprotected”

“Read Sector Protection Register completed”

Entering into Byte Program execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Byte Program is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Byte Program is not allowed”

if CSB deasserted in wrong point of time, following print will appear and operation will get aborted:

“Chip Select deasserted in non-even point. Byte/Page Program is not allowed”

If WEL bit is not set:

“WEL bit not set. Byte Program is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected. Byte Program cannot be performed”

“Sector for Address XXXXXX is UnProtected, Byte Program can be performed”

“Byte write completed”

Entering into Sequential Byte Program execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. Sequential Byte Program is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. Sequential Byte Program is not allowed”

if the sequential operation reaches end of memory:

“Sequential Byte Program for device reaches end of memory. No Wrapping allowed. Sequential Byte Program is not allowed”

If WEL bit is not set:

“WEL bit not set. Sequential Byte Program is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected. Sequential Byte Program cannot be performed”

“Sector for Address XXXXXX is Unprotected, Sequential Byte Program can be performed”
“Sequential Byte write completed”

Entering into 4KB Block Erase execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. 4KB Block Erase is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. 4KB Block Erase is not allowed”

If WEL bit is not set:

“WEL bit not set. 4KB Block Erase is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected. 4KB Block Erase cannot be performed”

“Sector for Address XXXXXX is Unprotected, 4KB Block Erase can be performed”

“4kB Block with start address XXXXXX erased”

Entering into 32KB Block Erase execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. 32KB Block Erase is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. 32KB Block Erase is not allowed”

If WEL bit is not set:

“WEL bit not set. 32KB Block Erase is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected. 32KB Block Erase cannot be performed”

“Sector for Address XXXXXX is Unprotected, 32KB Block Erase can be performed”

“32KB Block with start address XXXXXX erased”

Entering into 64KB Block Erase execution, following printing will appear:

If device is busy(RDYnBSY==1):

“Device is busy. 64KB Block Erase is not allowed”

if frequency exceeds specified fSCK:

“WARNING: Frequency should be less than XX MHz for SPI interface. 64KB Block Erase is not allowed”

if WEL bit is not set:

“WEL bit not set. 64KB Block Erase is not allowed”

Based on sector protection condition any one of the following print will appear:

“Sector for Address XXXXXX is Protected. 64KB Block Erase cannot be performed”

Sector for Address XXXXXX is UnProtected, 64KB Block Erase can be

performed”
 64kB Block with start address XXXXXX erased”

Entering into Chip Erase execution, following printing will appear:

If device is busy(RDYnBSY==1):
 “Device is busy. Chip Erase is not allowed”
 if frequency exceeds specified fSCK:
 “WARNING: Frequency should be less than XX MHz for SPI interface. Chip Erase is not allowed”
 if WEL bit is not set:
 “WEL bit not set. Chip Erase is not allowed”
 Based on sector protection condition any one of the following print will appear:
 “All Sectors in the chip are Unprotected. Chip Erase can be performed”
 “Some or all Sectors in the chip is Protected. Chip Erase cannot be performed”
 Chip Erase Completed”

if the input clock frequency (fSCK) exceeds maximum limit, following printing will appear:
 Frequency exceeds max limit (14285 ms). Time period detected is XX”

7. Signals and Events of testbench_AT26DFx.v module:

This module is responsible for sending opcode, address and data. Based on which particular trigger input asserted, corresponding opcode, address and data transfer will start. For example, if tr_byt_prog is asserted, then the byte programming opcode will be transferred in serial_in line in serial manner. Then the address obtained through m_address is transmitted serially. data_num will intimate the number of data to be written into the memory. Based on the data_num value, data in w_data will be transmitted serially through serial_in. The testbench_AT26DFx.v module has HOLDB control. Hence can be passed based on HOLDB value.

7.1 Port Signals:

Port	Signal name	Purpose
Input	clk	Clock input
Input	HOLDB	Hold
Input	SO_data	SO from BFM
Input	tr_read_stat	trigger for read status reg
Input	tr_write_stat	trigger for write status reg
Input	tr_wr_en	trigger for Write Enable
Input	tr_wr_dis	trigger for Write Disable
Input	tr_man	trigger for read Manufacturer ID
Input	tr_pwr_dwn	trigger for Deep Power-Down
Input	tr_res_pwr_dwn	trigger for resume from Deep Power-Down
Input	tr_byt_prog	trigger for Byte programming

Port	Signal name	Purpose
Input	tr_rd_array	trigger for Read array
Input	tr_rd_array_1	trigger for Read array in low frequency
Input	tr_seq_byt	trigger for Sequential programming
Input	tr_protect	trigger for Protect sector
Input	tr_unprotect	trigger for Unprotect sector
Input	tr_rd_protect	trigger for read protection register
Input	tr_be4	trigger for 4KB Block erase
Input	tr_be32	trigger for 32KB Block erase
Input	tr_be64	trigger for 64KB Block erase
Input	tr_ce	trigger for Chip erase
Input	data_num	no. of data to be transmitted/read
Input	no_addr	No address for consecutive sequential programming
Input	m_address	address for protect/unprotect/read arrays/programming/erase
Input	w_data	write data for Byte programming / Sequential programming
Output	serial_in	SI for BFM
Output	out_data	data from read array to top

7.2 Top level signals:

Signal name	Purpose
read_status	opcode for read status reg
write_status	opcode for write status reg
write_enable	opcode for Write Enable
write_disable	opcode for Write Disable
manufacturer	opcode for Manufacturer ID
deep_power_down	opcode for Deep Power-Down
res_deep_power	opcode for resume from Deep Power-Down
byte_program	opcode for Byte programming
read_array	opcode for Read array
read_array_1	opcode for Read array in low frequency
seq_program	opcode for Sequential programming
protect	opcode for Protect sector
unprotect	opcode for Unprotect sector
read_protect	opcode for read protection register
erase_4	opcode for 4KB Block erase
erase_32	opcode for 32KB Block erase
erase_64	opcode for 64KB Block erase
chip_erase	opcode for Chip erase
x_val	don't care values for Read array in low frequency

7.3 List of events:

<i>Event</i>	<i>Purpose</i>
read_stat	read status reg
wr_en	Write Enable
wr_dis	Write Disable
manufact	Manufacturer ID
pwr_dwn	Deep Power-Down
res_pwr_dwn	resume from Deep Power-Down
byt_prog	Byte programming
rd_array	Read array
rd_array_l	Read array for low frequency
seq_byte	Sequential programming
protect_sector	Protect sector
unprotect_sector	Unprotect sector
read_sector	read protection register
write_stat	write status reg
erase4	4KB Block erase
erase32	32KB Block erase
erase64	64KB Block erase
erase_chip	Chip erase

7.4 List of parameters:

tDS : Data in Setup time
tDH : Data in Hold time

8. Signals and Events of topx_testbench.v module:

topx_testbench.v module is responsible for selecting the device for which the model has to work, sending opcode, address and data in SI line and obtaining the read array data from SO line. It also passes all the parameter needed for the device model (AT26DFxxx.v) internally. It contains all the test cases to test the model for each device model (AT25DF041A, AT26DF081A, AT26DF161A, and AT26DF321) and also for all the possibilities of error conditions.

8.1 Top level signals:

<i>Signal</i>	<i>Purpose</i>
trg_read_stat	trigger for read status reg
trg_write_stat	trigger for write status reg
trg_wr_en	trigger for Write Enable
trg_wr_dis	trigger for Write Disable
trg_man	trigger for read Manufacturer ID

<i>Signal</i>	<i>Purpose</i>
trg_pwr_dwn	trigger for Deep Power-Down
trg_res_pwr_dwn	trigger for resume from Deep Power-Down
trg_byt_prog	trigger for Byte programming
trg_rd_array	trigger for Read array
trg_rd_array_l	trigger for Read array in low frequency
trg_seq_byt	trigger for Sequential programming
trg_protect	trigger for Protect sector
trg_unprotect	trigger for Unprotect sector
trg_rd_protect	trigger for read protection register
trg_be4	trigger for 4KB Block erase
trg_be32	trigger for 32KB Block erase
trg_be64	trigger for 64KB Block erase
trg_ce	trigger for Chip erase
t_data_num	no. of data to be transmitted/read
t_no_addr	No address for consecutive sequential programming
address	address for protect/unprotect/read arrays/programming/erase
data	write data for Byte programming / Sequential programming
CSB_out	CSB signal for BFM
WPB_out	WPB signal for BFM
HOLDB_out	HOLDB signal for BFM
SO_in	SO from BFM
SI_out	SI for BFM
SCK_out	SCK for BFM

8.2 List of parameters:

<i>Parameter</i>	<i>Purpose</i>
fRDLF	SCK Frequency for read Array (Low freq - 03h opcode)
fSCK	Serial clock (SCK) Frequency in MHz
tSCKH	SCK High time
tSCKL	SCK Low time
tCSH	Chip Select high time
tCSLS	Chip Select Low Setup time
tCSLH	Chip Select Low hold time
tCSHS	Chip Select high Setup time
tCSHH	Chip Select high hold time
tDS	Data in Setup time
tDH	Data in Hold time
tHLS	HOLD! Low Setup Time
tHHS	HOLD! High Setup Time
tHLH	HOLD! Low Hold Time
tHHH	HOLD! High Hold Time
tWPS	Write Protect Setup Time (only when SPRL=1)
tWPH	Write Protect Hold Time (only when SPRL=1)

<i>Parameter</i>	<i>Purpose</i>
tWRSR	Write Status Register Time
tSECP	Sector Protect Time
tSECUP	Sector Unprotect Time
tEDPD	Chip Select high to Deep Power-down (3 us)
tRDPD	Chip Select high to Stand-by Mode
tPP	Page Program Time
tBP	Byte Program Time
tBLKE4	Block Erase Time 4-kB (0.350 sec)
tBLKE32	Block Erase Time 32-kB
tBLKE64	Block Erase Time 64-kB
tCHPE	Chip erase time
DEVICE	Specifies the selected card model
PRELOAD	Memory preloading condition
MEMORY_FILE	Memory preload file

8.3 List of Switches:

<i>Switch</i>	<i>Switch status</i>
`041	Selects device model for device AT25DF041A
`081	Selects device model for device AT26DF081A
`161	Selects device model for device AT26DF161A
`321	Selects device model for device AT26DF321
MODE3	Selects SPI mode 3
LOAD	Selects Memory preloading with the content in memory.txt

Any one of the 4 switches (041 / 081 / 161 / 321) has to be selected for proper selection of device parameters in AT26DFxxx.v model.

For SPI mode of operation, default is SPI mode0. If switch MODE3 is selected, then SPI mode3 operation will be carried out.

LOAD switch can be used to preload the card memory with values specified in memory.txt file. If LOAD switch is not used, then memory is preloaded with erased state.

For selecting a particular ATMEL DataFlash model, only any one of 4 switches need to be selected. All other parameters like maximum frequency, timing for SI, SO, HOLDB, CSB, and WPB will internally passed to the corresponding modules.

9. Tasks used in topx_testbench.v module:

For **deep power down, resume from deep power down, read manufacturer ID, chip erase, write enable and write disable** only opcode need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH2$ (+ $*32*tSCKH$ for read

manufacturer ID alone). For deep power down, resume from deep power down and chip erase, additional delay of tEDPD, tRDPD, tCHPE is given respectively to complete the operation.

For **read array in low and high frequency**, opcode and address need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH + 2*24*tSCKH(+ 2*8*tSCKH$ this delay is for read array in high frequency alone. Not for low frequency)+ the time to receive data in SO.

For **protect, unprotect and read sector protection**, opcode and address need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH + 2*24*tSCKH$ (+ the time to receive data in SO (for read sector protection)). Additional delay of tSECP (for protect sector) or tSECUP (for unprotect sector).

For **4KB erase, 32KB erase and 64KB erase**, opcode and address need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH + 2*24*tSCKH$. Additional delay of tBLKE4 (4KB erase) or tBLKE32 (for 32KB erase) or tBLKE64 (for 64KB erase) is issued to complete the operation.

For **Byte/Page programming**, opcode, address and data need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH + 2*24*tSCKH + 2*(t_data_num)*tSCKH$ (this delay is for sending data in SI). Additional delay of tPP is issued to complete the operation. t_data_num represents the number of data that is going to be transferred.

For **Sequential Byte programming**, for the first time, opcode, address and data need to be supplied. Hence particular trigger signal is asserted and deasserted after $2*8*tSCKH + 2*24*tSCKH + 2*8*tSCKH$ (this delay is for sending data in SI). Additional delay of tBP is issued to complete the operation. For the second time onwards opcode and data need to be supplied. Hence particular trigger signal is asserted and deasserted after $2*8*tSCKH + 2*8*tSCKH$ (this delay is for sending data in SI). Additional delay of tBP is issued to complete the operation.

For **write status register**, opcode and data need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH(opcode) + 2*8*tSCKH(data)$. Additional delay of tWRSR is issued to complete the operation.

For **read status register**, only opcode need to be supplied. Hence particular trigger signal and CSB are asserted and deasserted after $2*8*tSCKH(opcode) + 2*(min 1 and max as needed)*tSCKH$.

10. Status and Error printing of topx_testbench.v module:

For data validation any on of these two prints will appear.

If written data and read data are correct,

“Write Data: XX, Read Data: XXXXXX Valid Data received”

If written data and read data are incorrect,

“Write Data: XX, Read Data: XXXXXX Invalid Data received”

11. Instantiation of memory model and test cases in different EDA Tools:

The verilog memory model doesn't need any change for instantiating in both ModelSim and in VCS. Only the script need to be changed. All the verilog files (device model, testbench and top) should be kept in a folder and filelist.v file should contain path to access these three files.

For example if all these 3 files kept in a folder, filelist.v can contain:

```
top26x_testbench.v
AT26DFxxx.v
testbench_AT26DFx.v
```

For memory preloading condition, memory.txt should be kept at the working directory, where compilation and simulation takes place.

11.1 For VCS all possible scripts are listed below:

For SPI MODE0 operation

```
vcs -R -PP +define+041 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT25DF041A in SPI Mode0
vcs -R -PP +define+081 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF081A in SPI Mode0
vcs -R -PP +define+161 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF161A in SPI Mode0
vcs -R -PP +define+321 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF321 in SPI Mode0
```

For SPI MODE3 operation

```
vcs -R -PP +define+041+MODE3 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT25DF041A in SPI Mode3
vcs -R -PP +define+081+MODE3 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF081A in SPI Mode3
vcs -R -PP +define+161+MODE3 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF161A in SPI Mode3
vcs -R -PP +define+321+MODE3 +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF321 in SPI Mode3
```

For card memory preloading, few example is given below:

```
vcs -R -PP +define+321+LOAD +vcs+lic+wait -f filelist.v -l at26x.log
above used for compilation and simulation for device AT26DF321 in SPI Mode0 with memory
preloaded with data in memory.txt.
```

```
vcs -R -PP +define+081+MODE3 +vcs+lic+wait -f filelist.v -l at26x.log
```


above used for compilation and simulation for device AT26DF081A in SPI Mode3 with memory preloaded with data in memory.txt.

11.2 For ModelSim all possible scripts are listed below:

For the first time these two lines need to be executed for creating work library.

vlib work

vmap work work

For SPI MODE0 operation

vlog +define+041 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT25DF041A in SPI Mode0

vlog +define+081 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF081A in SPI Mode0

vlog +define+161 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF161A in SPI Mode0

vlog +define+321 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF321 in SPI Mode0

For

SPI

MODE3

operation

vlog +define+041 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT25DF041A in SPI Mode3

vlog +define+081 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF081A in SPI Mode3

vlog +define+161 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF161A in SPI Mode3

vlog +define+321 -novopt -f fileslist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF321 in SPI Mode3

For card memory preloading, few example is given below:

vlog +define+161+LOAD -novopt -f filelist.v +acc -R -c -do "run -all" -l at26x.log -

above used for compilation and simulation for device AT26DF321 in SPI Mode0 with memory preloaded with data in memory.txt.

vlog +define+041+MODE3+LOAD -novopt -f filelist.v +acc -R -c -do "run -all" -l at26x.log

above used for compilation and simulation for device AT26DF081A in SPI Mode3 with memory preloaded with data in memory.txt.